# **High Capacitance Tantalum Solid Electrolytic Chip Capacitors Undertab Series**





#### **FEATURES**

- · Large Case Size for Maximum Capacitance
- 3x Reflow 260°C Compatible
- 100% Surge Current Tested
- · Low Profile Solution
- **Consumer Applications** (e.g. PCMCIA/USB Wireless Express Cards etc.)
- CV Range: 1000-3300µF / 4-10V
- · 2 Case Sizes Available

## **APPLICATIONS**

- · Data Transfer Modems
- · SSD Backup Circuits





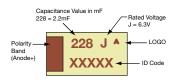
#### **CASE DIMENSIONS:**

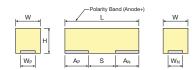
## millimeters (inches)

Code	EIA Code	EIA Metric	L±0.20 (0.008)	W+0.20 (0.008) -0.10 (0.004)	H max.	W <sub>P</sub> ±0.10 (0.004)	W <sub>N</sub> ±0.10 (0.004)	A <sub>P</sub> ±0.10 (0.004)	A <sub>N</sub> ±0.10 (0.004)	S Min.
4	2924	7361-20	7.30 (0.287)	6.10 (0.240)	2.00 (0.079)	4.75 (0.187)	4.75 (0.187)	2.00 (0.079)	3.20 (0.126)	2.10 (0.083)
6	5831	14878-20	14.80 (0.583)	7.80 (0.307)	2.00 (0.079)	5.50 (0.217)	5.50 (0.217)	2.45 (0.096)	2.45 (0.096)	9.90 (0.390)

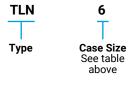
### **MARKING**

### **4,6 CASE**



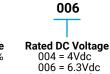


# **HOW TO ORDER**









010 = 10 Vdc







ESR in  $m\Omega$ 

### **TECHNICAL SPECIFICATIONS**

Technical Data:	All technical data relate to an ambient temperature of +25°C								
Capacitance Range:			1000 μF to 3300 μF						
Capacitance Tolerance:			±20%						
Leakage Current DCL:		0.01CV							
Rated Voltage $(V_R)$ $-55^{\circ}C \le +40^{\circ}C$ :		4	6.3	10					
Category Voltage (V <sub>c</sub> )	at 85°C:	2	3.2	5					
Category Voltage (V <sub>c</sub> )	at 125°C:	0.8	1.3	2					
Temperature Range:		-55°C to	+125°C v	with cate	gory voltage				
Reliability:		$0.2\%$ per 1000 hours at $85^{\circ}\text{C}$ , $0.5\text{xV}_{R}$ with $0.1\Omega/V$ series impedance with $60\%$ confidence level							





# **CAPACITANCE AND RATED VOLTAGE RANGE** (LETTER DENOTES CASE SIZE)

Capac	itance	Voltage Rating DC (VR) to 85°C							
μF	Code	4V (G)	6.3V (J)	10V (A)					
680	687								
1000	108			4(100)/6(55)					
1500	158		4(100)	6(55)					
2200	228		6(55)						
3300	338	6(55)							

Released ratings (ESR ratings in mOhms in parentheses)

Note: Voltage ratings are minimum values. KYOCERA AVX reserves the right to supply higher voltage ratings in the same case size, to the same reliability standards.

### **RATINGS & PART NUMBER REFERENCE**

	Case	Capacitance	Rated	Rated Temperature (°C)	Category Voltage (V)	Category Temperature (°C)	DCL Max. (µA)	ESR Max.	100kHz RMS Current (mA)			
Part Number	Size	(μ <b>F</b> )	Voltage (V)					@ 100kHz (mΩ)	25°C	85°C	125°C	MSL
4 Volt @ 40°C												
TLN6338M004#0055	6	3300	4	40	0.8	125	132	55	2045	1840	818	3
	6.3 Volt @ 40°C											
TLN4158M006#0100	4	1500	6.3	40	1.3	125	90	100	1285	1156	514	3
TLN6228M006#0055	6	2200	6.3	40	1.3	125	132	55	2045	1840	818	3
	10 Volt @ 40°C											
TLN4108M010#0100	4	1000	10	40	2	125	100	100	1285	1156	514	3
TLN6108M010#0055	6	1000	10	40	2	125	100	55	2045	1840	818	3
TLN6158M010#0055	6	1500	10	40	2	125	150	55	2045	1840	818	3

Moisture Sensitivity Level (MSL) is defined according to J-STD-020.

All technical data relates to an ambient temperature of +25°C. Capacitance and DF are measured at 120Hz, 0.5V RMS with a maximum DC bias of 2.2 volts.

DCL is measured at rated voltage after 5 minutes.

ESR allowed to move up to 1.25 times catalogue limit post mounting

DCL allowed to move up to 2.00 times catalogue limit post mounting

For typical weight and composition, see page 253.

NOTE: KYOCERA AVX reserves the right to supply higher voltage ratings or tighter tolerance part in the same case size, to the same reliability standards.

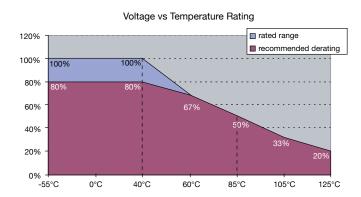
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## **QUALIFICATION TABLE**

TEST	TLN PulseCap™ series (Temperature range -55°C to +125°C)											
IESI		Condition		Characteristics								
	Apply rated voltage	ge (Ur) at 40°C and	/ or category	Visual examination no visible damage								
Endurance		5°C for 2000 hours		DCL	2 x initial limit							
Endurance	1 '	.1Ω/V. Stabilize at ro	ΔC/C	within +	within +5/-30% of initial value							
	for 1-2 hours befo	ore measuring.		ESR	1.25 x initial limit							
	Store at 65°C and	d 90-95% relative hu	Visual examination	no visible damage								
		plied voltage. Stabil	DCL	2 x initia	2 x initial limit							
Humidity		humidity for 1-2 hou	ΔC/C	within ±	within ±10% of initial value							
	measuring.			ESR	1.25 x ir	itial limit		value  value  value  20°C				
	Step	Temperature°C	Duration(min)		+20°C	-55°C	+20°C	+85°C	+125°C	+20°C		
Tomporoturo	1 2	+20 -55	15 15	DCL	2 x IL*	n/a	2 x IL*	20 x IL*	25 x IL*	2 x IL*		
Temperature Stability	3	+20 +85	15 15	ΔC/C	n/a	+5/-20%			-			
Otubility	5	+125	15					-,	-			
	6	+20	15	ESR	1.25xIL*			1.25 x IL*	1.25 x IL*	125xIL*		
	Apply 1.3x rated v	voltage (Ur) at 40°C	for 1000 cycles	Visual examination		<u> </u>						
Surge		(30 sec charge, 5 n	DCL	2 x initia	2 x initial limit							
Voltage	J , ,	gh a charge / discha	ΔC/C	within ±5% of initial value								
	of 1000Ω			ESR	1.25 x ir	itial limit			25 x IL* 2 x IL*			
				Visual examination	2 x initial limit within ±5% of initial value 1.25 x initial limit n o visible damage initial limit							
N4 l ! I				DCL	initial limit							
Mechanical Shock	MIL-STD-202, Me	thod 213, Condition	ΔC/C	within ±	within ±5% of initial value							
SHOCK				DF	initial lin	initial limit						
				ESR	initial lin	initial limit						
				Visual examination	no visib	no visible damage						
	MIL-STD-202, Method 204, Condition D			DCL	initial limit							
Vibration				ΔC/C	within ±	within ±5% of initial value						
				DF	initial limit							
			ESR	initial limit								

<sup>\*</sup>Initial Limit

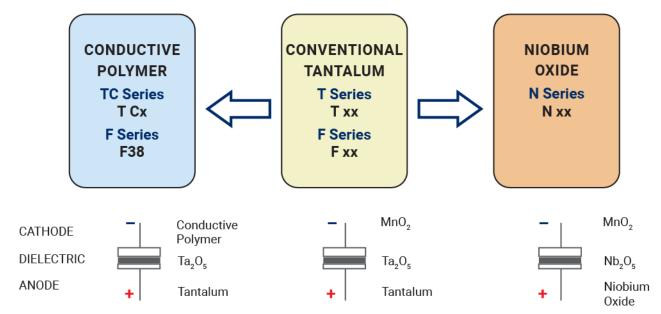


TDS-PTNO-0003 | Rev 1

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#### SOLID ELECTROLYTIC CAPACITOR ROADMAP



## **FIVE CAPACITOR CONSTRUCTION STYLES**



## **SERIES LINE UP: CONVENTIONAL SMD MnO**,

